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http://www.ltalab.com

EMC TEST REPORT

Dates of Tests: April 23 - 26, 2019 Test Report S/N: LR500122108A

Test Site: LTA Co., Ltd.

Model No.

QNO-6082R

APPLICANT

Hanwha Techwin Co., Ltd.

Equipment Name : NETWORK CAMERA

Manufacturer : Hanwha Techwin Co., Ltd.

Model name : QNO-6082R

Additional Model name : QNO-6072R, QNO-6082R1, QNO-6072R1

Test Device Serial No.: : Identification

Directive : Electromagnetic Compatibility Directive 2014/30/EU

Rule Part(s) : EN 55032:2015/A11:2020

EN 50130-4:2011/A1:2014

EN 61000-3-2:2014

EN 61000-3-3:2013

Data of reissue : August 10, 2021

This test report is issued under the authority of:

The test was supervised by:

Young Kyu Shin, Technical Manager

Joo Hyung Cho, Test Engineer

This test result only responds to the tested sample. It is not allowed to copy this report even partly without the allowance of the test laboratory. The report must not be used by the client to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.

This test report is not related to KS Q ISO/IEC 17025 and KOLAS accreditation.



Revision	Date of issue	Test report No.	Description	
0	29.04.2019	LR500121904BE	Initial	
1	10.08.2021	LR500122108A	Rule Update, Delete China Factory, Add Additional Models	
			(QNO-6082R1, QNO-6072R1)	

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1. General information's

1-1 Test Performed

Company name : LTA Co., Ltd

Address : 4, Songju-ro 236beon-gil, Yangji-myeon, Cheoin-gu, Yongin-si,

Gyeonggi-do, 17159, Korea

Web site : http://www.ltalab.com

E-mail : <u>chahn@ltalab.com</u>
Telephone : +82-31-323-6008
Facsimile +82-31-323-6010

Quality control in the testing laboratory is implemented as per ISO/IEC 17025 which is the "General requirements for the competents of calibration and testing laboratory".

1-2 Accredited agencies

LTA Co., Ltd. is approved to perform EMC testing by the following agencies:

Agency	Country	Accreditation No.	Validity	Reference
NVLAP	U.S.A	200723-0	2021-09-30	ECT accredited Lab.
	KOREA		-	
RRA	U.S.A	KR0049	2023-04-08	RRA accredited Lab.
	CANADA		2022-10-18	
		C-14948	2023-09-10	
VCCI	JAPAN	T-12416	2023-09-10	VCCI registration
VCCI	JAFAN	R-14483	2023-10-15	veer registration
		G-10847	2021-12-13	
KOLAS	KOREA	KT551	2021-08-20	KOLAS accredited Lab.

2. Information's about test item

2-1 Client/ Manufacturer

Company name : Hanwha Techwin Co., Ltd.

Address : 8-10, TECHNO 3-RO, YUSEONG-GU, DAEJEON, KOREA

Telephone / Facsimile : +82-31-723-5205 / +82-31-723-5108

Factory #1

Company name : HANWHA TECHWIN SECURITY VIETNAM CO.,LTD.

Address Lot O-2, Que Vo Industrial Zone extended area ,Nam Son commune, Bac Ninh

city,Bac Ninh province, Vietnam

Factory #2

Company name : D-TECH CO.,LTD.

Address 173-25, Saneop-ro, Gwonseon-gu, Suwon-si, Gyeonggi-do, Korea (Suwon Industrial

Complex)

2-2 Equipment Under Test (EUT)

Class : A

Equipment Name : NETWORK CAMERA

Model name : QNO-6082R

Additional Model name : QNO-6072R, QNO-6082R1, QNO-6072R1

Additional Models are different only lens specification.

Serial number : Identification

Date of receipt : April 09, 2019

EUT condition : Pre-production, not damaged

Interface ports DC IN, LAN, Alarm IN, Alarm OUT, GND, Micro SD, MIC

Video OUT Port is a management Port.

Power rating : DC 12 V (Adapter), DC 48 V (POE)

2-3 Modification

-NONE

2-4 Test conditions

Temp. / Humid. / Pressure : +(21-24) °C / (31-41) % R.H. / (101) kPa

Tested Model : QNO-6082R

Test mode : REC mode (Adapter), REC mode (POE)

Tested Voltage : AC 230 V, 50 Hz (Adapter), DC 48 V (POE)

2-5 EUT

Equipment	Model No.	Serial No.	Manufacturer
NETWORK CAMERA	QNO-6082R	N/A	HANWHA TECHWIN SECURITY VIETNAM CO.,LTD. D-TECH CO.,LTD.

2-6 Accessary / REC mode (Adapter)

Equipment	Model No.	Serial No.	Manufacturer
EUT Adapter	F12L2-120100SPAK	N/A	SHENZHEN FRECOM ELECTRONKS CO.,LTD.
Alarm #1	N/A	N/A	N/A
Alarm #2	SPL-0030	N/A	SECOM
Smart Phone	SHV-E210L	R33C9026JXE	SAMSUNG
Notebook	P56	NKW650RB0006A02845	HANSUNG
			Chicony Power
Notebook Adapter	A10-090P3A	F180261552004253	Technology
			(SUZHOU)CO.,LTD.
Micro SD Card	MB-MP32D	MBMPBGVEODFW-F	SAMSUNG

/ REC mode (POE)

Equipment	Model No.	Serial No.	Manufacturer
Alarm #1	N/A	N/A	N/A
Alarm #2	SPL-0030	N/A	SECOM
Smart Phone	SHV-E210L	R33C9026JXE	SAMSUNG
Notebook	P56	NKW650RB0006A02845	HANSUNG
Notebook Adapter	A10-090P3A	F180261552004253	Chicony Power Technology (SUZHOU)CO.,LTD.
Micro SD Card	MB-MP32D	MBMPBGVEODFW-F	SAMSUNG
POE Injector	PSE305	N/A	N/A

2-7 Cable List / REC mode (Adapter)

From		То		Length	Shi	elding
Type	I/O Port	Type I/O Port		(m)	Cable	backshell
	DC IN	EUT Adapter	DC OUT	1.4	NO	Plastic
	ARM-IN	Alarm #1	-	1.2	NO	Plastic
	GND	Alarm #1	-	1.2	NO	Plastic
EUT	ARM-OUT	Alarm #2	-	1.8	NO	Plastic
EUT	GND	Alarm #2	-	1.8	NO	Plastic
	MIC	Smart Phone	AUX	1.6	NO	Plastic
	LAN	Notebook	LAN	3.0	NO	Plastic
	Micro SD	Micro SD Card	-	-	-	-
Notebook	DC IN	Notebook Adapter	DC OUT	1.2	NO	Plastic

/ REC mode (POE)

From		То		Length	ength Shielding	
Type	I/O Port	Type I/O Port		(m)	Cable	backshell
	LAN	POE Injector	P+D/OUT	3.0	NO	Plastic
	ARM-IN	Alarm #1	-	1.2	NO	Plastic
	GND	Alarm #1	-	1.2	NO	Plastic
EUT	ARM-OUT	Alarm #2	-	1.8	NO	Plastic
	GND	Alarm #2	-	1.8	NO	Plastic
	MIC	Smart Phone	AUX	1.6	NO	Plastic
	Micro SD	Micro SD Card	-	-	-	-
DOE Injector	Data/IN	Notebook	LAN	3.0	NO	Plastic
POE Injector	AC IN	AC Power Source	3 Pin AC Line	1.2	NO	Plastic
Notebook	DC IN	Notebook Adapter	DC OUT	1.2	NO	Plastic

3. Test Report

3.1 Summary of tests

Parameter	Applied Standard	Status				
	I. Emission					
Radiated Emission	EN 55032:2015/A11:2020	С				
Conducted Emission	EN 55032:2015/A11:2020	С				
Harmonic Current Emission	EN 61000-3-2:2014	N/A Note3				
Voltage Fluctuations and Flicker	EN 61000-3-3:2013	С				
	II. Immunity					
Electrostatic Discharge	EN 61000-4-2:2009	C				
RF Electromagnetic field	EN 61000-4-3:2006/A1:2008/A2:2010	С				
Fast Transients Common mode	EN 61000-4-4:2012	С				
Surges, line to line and line to ground	EN 61000-4-5:2014/A1:2017	С				
RF common mode	EN 61000-4-6:2014/AC:2015	С				
Voltage dips and Interruptions	EN 61000-4-11:2004/A1:2017	С				
Main supply voltage variations	EN 50130-4:2011/A1:2014	С				

Note 1: C=Complies NC=Not Complies NT=Not Tested NA=Not Applicable

Note 2: The data in this test report are traceable to the national or international standards.

<u>Note 3:</u> We did not test EN61000-3-2 (Harmonic current emissions) for the QNO-6082R because equipment whose rated power is less or equal 75W don't need to be tested.

3.2 EMISSION

3.2.1 Conducted emissions

Definition:

The test assesses the ability of the EUT to limit its internal noise from being present on the AC mains Power In/Output ports.

We were performed the test according to LTA procedure LTA-QI-04.

Measurement Frequency range : 150 kHz – 30 MHz

Test method : EN 55032:2015/A11:2020

Measurement RBW : 9 kHz

Test mode : REC mode (Adapter), REC mode (POE)

Result : Complies

Measurement Data:

- Refer to the Next page (Maximum emission configuration)

A sample calculation:

COR. F (correction factor)= LISN Insertion loss + Cable loss + Pulse Limiter Factors

Emission Level= meter reading + COR.F

Limits for conducted disturbance at the mains ports of class A ITE

Frequency Range	Quasi-peak	Average
(0.15 – 0.5) MHz	79 dBuV	66 dBuV
(0.5 – 30) MHz	73 dBuV	60 dBuV

Note: The limits will decrease with the frequency logarithmically within 0.15MHz to 0.5MHz

Limits for conducted disturbance at the mains ports of class B ITE

Frequency Range	Quasi-peak	Average
(0.15 – 0.5) MHz	(66 – 56) dBuV	(56 - 46) dBuV
(0.5 – 5) MHz	56 dBuV	46 dBuV
(5 – 30) MHz	60 dBuV	50 dBuV

Note: The limits will decrease with the frequency logarithmically within $0.15\ \text{MHz}$ to $0.5\ \text{MHz}$

Limits of conducted common mode (asymmetric mode) disturbance at telecommunication ports in the frequency range 0.15 MHz to 30 MHz for class A equipment

r n	Voltage limits		Current limits	
Frequency Range	Quasi-peak	Average	Quasi-peak	Average
(0.15 - 0.5) MHz	(97 – 87) dBuV	(84 – 74) dBuV	(53 – 43) dBuV	(40 – 30) dBuV
(0.5 – 30) MHz	87 dBuV	74 dBuV	43 dBuV	30 dBuV

Note 1: The limits decrease linearly with the logarithm of the frequency in the range 0.15 MHz to 0.5 MHz.

Note 2: The current and voltage disturbance limits are derived for use with an impedance stabilization network (ISN) which presents a common mode (asymmetric mode) impedance of 150Ω to the telecommunication port under test (conversion factor is $20 \log_{10} 150/I=44 dB$)

Limits of conducted common mode (asymmetric mode) disturbance at telecommunication ports in the frequency range 0.15 MHz to 30 MHz for class B equipment

Enagyan ay Dan aa	Voltage	e limits	Current limits		
Frequency Range	Quasi-peak	Average	Quasi-peak	Average	
(0.15 – 0.5) MHz	(84 – 74) dBuV	(74 – 64) dBuV	(40 – 30) dBuV	(30 – 20) dBuV	
(0.5 – 30) MHz	74 dBuV	64 dBuV	30 dBuV	20 dBuV	

Note 1: The limits decrease linearly with the logarithm of the frequency in the range 0.15 MHz to 0.5 MHz.

Note 2: The current and voltage disturbance limits are derived for use with an impedance stabilization network (ISN) which presents a common mode (asymmetric mode) impedance of 150Ω to the telecommunication port under test (conversion factor is $20 \log_{10} 150/I=44 dB$)

Conducted emissions (LINE) / REC mode (Adapter)



4, Songjuro 236 Beon-gil, Yangji-myeon Cheoin-gu, Youngin-si, Gyeonggi-do 449-822 Korea

Tel:+82-31-3236008,9 Fax:+82-31-3236010

EUT /Model No. : QNO-6082R

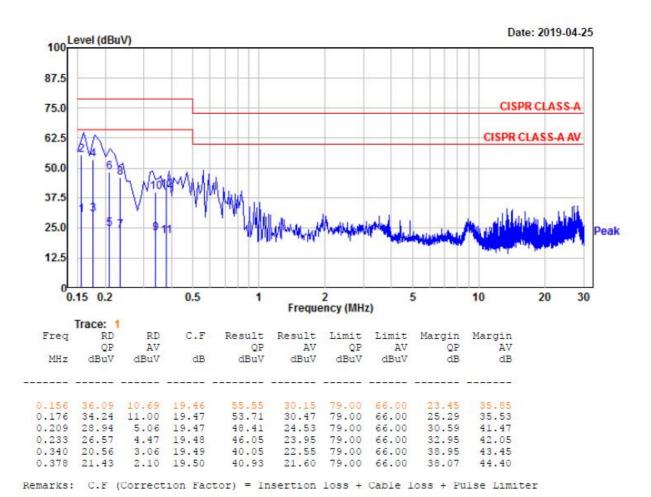
Test Mode : REC mode (Adapter)

Temp./ Humi. : 24°C / 41% R.H.

Phase : Line

Test Power : 230 / 50

Test Engineer : CHOI Y H



Conducted emissions (NEUTRAL) / REC mode (Adapter)



4, Songjuro 236 Beon-gil, Yangji-myeon Cheoin-gu, Youngin-si, Gyeonggi-do 449-822 Korea

Tel:+82-31-3236008,9 Fax:+82-31-3236010

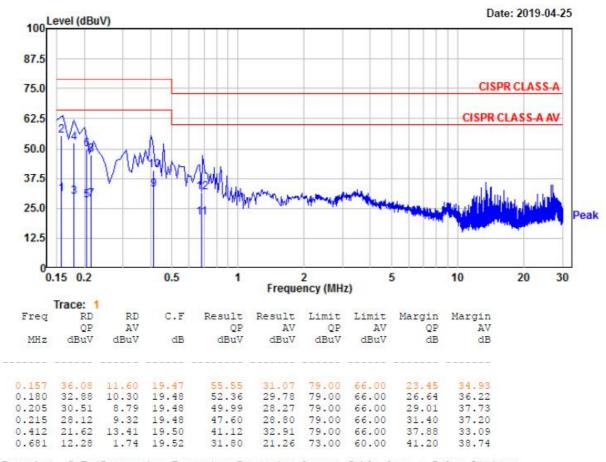
EUT /Model No.: QNO-6082R

Test Mode : REC mode (Adapter)

Temp./ Humi. : 24'C / 41% R.H.

(Adapter)

Phase : Neutral
Test Power : 230 / 50
Test Engineer : CHOI Y H



Remarks: C.F (Correction Factor) = Insertion loss + Cable loss + Pulse Limiter

Conducted emissions (TEL 100 M) / REC mode (Adapter)



4, Songjuro 236 Beon-gil, Yangji-myeon Cheoin-gu, Youngin-si, Gyeonggi-do 449-822 Korea

Tel:+82-31-3236008,9 Fax:+82-31-3236010

EUT /Model No. : QNO-6082R

Test Mode : REC mode (Adapter)

Temp./ Humi. : 24'C / 41% R.H.

Phase : TEL 100M

Test Power : 230 / 50

Test Engineer : CHOI Y H

Date: 2019-04-25 100 Level (dBuV) CISPR CLASS-A TEL(QP) 87.5 CISPR CLASS-A TEL(AV) 75.0 62.5 50.0 Peak 37.5 25.0 12.5 0.15 0.2 10 20 30 Frequency (MHz) Trace: 1 RD RD C.F Result Result Limit Limit Margin Margin Freq QP AV QP AV AV OP AV OP dBuV dB dBuV dBuV dBuV dB dB MHz dBuV dBuV 53.20 87.00 74.00 54.97 87.00 74.00 20.80 33.52 19.68 35.26 19.71 13.358 33.95 53.63 33.37 35.71 14.213 55.42 31.58 19.03 30.20 87.00 74.00 59.25 87.00 74.00 10.49 19.71 39.49 19.76 15.083 32.18 51.89 35.11 43.80 16.229 39.90 59.66 27.34 14.75 50.79 87.00 74.00 23.128 34.07 30.82 19.97 54.04 23.21

Remarks: C.F (Correction Factor) = Insertion loss + Cable loss + Pulse Limiter

Conducted emissions (TEL 100 M) / REC mode (POE)



4, Songjuro 236 Beon-gil, Yangji-myeon Cheoin-gu, Youngin-si, Gyeonggi-do 449-822 Korea

Tel:+82-31-3236008,9 Fax:+82-31-3236010

EUT /Model No. : QNO-6082R

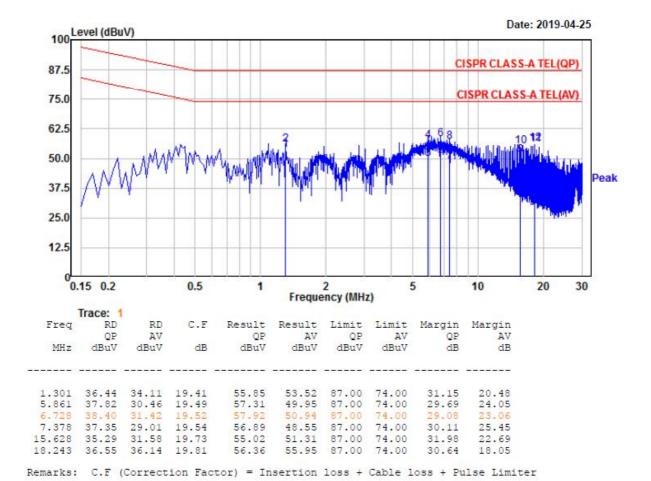
Test Mode : REC mode (POE)

Temp./ Humi. : 24'C / 41% R.H.

Phase : TEL 100M

Test Power : 230 / 50

Test Engineer : CHOI Y H



3.2.2 Radiated Emission

Definition:

The test assesses the ability of ancillary equipment to limit their internal noise from being radiated from the enclosure. We were performed the test according to LTA procedure LTA-QI-04.

Test method : EN 55032:2015/A11:2020

Measuring Distance : 10 m for below 1 GHz / 3 m for above 1 GHz

Measurement Frequency range : 30 MHz – 6 000 MHz

Measurement RBW : 120 kHz @ 10 m / 1 MHz @ 3 m

Test mode : REC mode (Adapter), REC mode (POE)

Result : Complies

Measurement Data:

- Refer to the Next page (Maximum emission configuration)

- The highest internal source of an EUT is higher than 108 MHz, the measurement shall be made up to 6 GHz. (The highest internal source of an EUT : 1 GHz)

A sample calculation:

COR. F (correction factor)= Antenna factor + Cable loss- Amp.gain- Distance correction Emission Level= meter reading + COR.F

Limit of 10 m for below 1 GHz

CLASS A

Frequency Range	Quasi-peak
(30 – 230) MHz	40 dBuV/m
(230 – 1 000) MHz	47 dBuV/m
CLASS B	
Frequency Range	Quasi-peak
(30 - 230) MHz	30 dBuV/m
(230 – 1 000) MHz	37 dBuV/m

Limit of 3m for above 1 GHz

CLASS A

Frequency Range	Average Limit @ 3m	Peak limit @ 3m	
rrequency Kange	$\left(dB\mu V/m\right)$	$\left(dB\mu V/m\right)$	
(1 000 – 3 000) MHz	56	76	
(3 000 – 6 000) MHz	60	80	
NOTE:	The lower limit applies a	t the transition frequency.	
CLASS B			
E D	Average Limit @ 3m	Peak limit @ 3m	
Frequency Range	$(dB\mu V/m)$	$\left(dB\mu V/m\right)$	
(1 000 – 3 000) MHz	50	70	
(3 000 – 6 000) MHz	54	74	
NOTE:	The lower limit applies at the transition frequency.		

Radiated Emission (Below 1 GHz) / V REC mode (Adapter)



4, Songjuro 236Beon-gil, yanggi-myeon,

Yongin-si, Gyeonggi-do, Korea

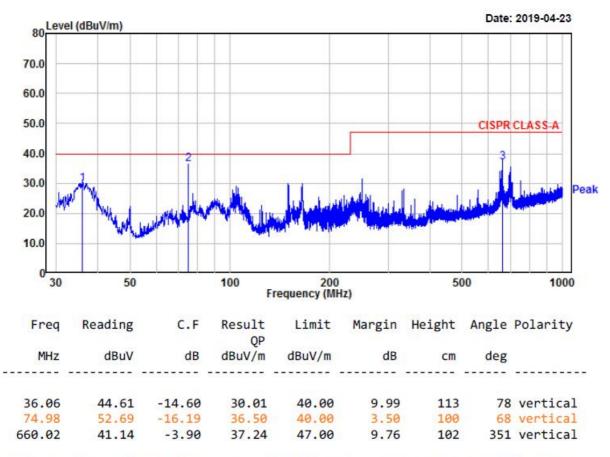
Tel: +82-31-3236008,9 Fax: +82-31-3236010

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EUT/Model No.: QNO-6082R Temp/Humi: 23 / 31

Test Mode

: REC mode (Adapter) Tested by: CHOI Y H



Remarks: C.F (Correction Factor) = Antenna factor + Cable loss - Preamp gain

Radiated Emission (Below 1 GHz) / H REC mode (Adapter)



4, Songjuro 236Beon-gil, yanggi-myeon,

Yongin-si, Gyeonggi-do, Korea

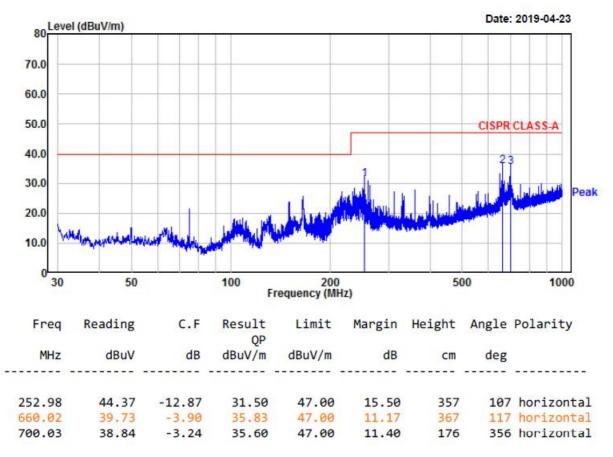
Tel: +82-31-3236008,9 Fax: +82-31-3236010

www.ltalab.com

EUT/Model No.: QNO-6082R Temp/Humi: 23 / 31

Test Mode

Tested by: CHOI Y H : REC mode (Adapter)



Remarks: C.F (Correction Factor) = Antenna factor + Cable loss - Preamp gain

Radiated Emission (Below 1 GHz) / V REC mode (POE)



4, Songjuro 236Beon-gil, yanggi-myeon,

Yongin-si, Gyeonggi-do, Korea

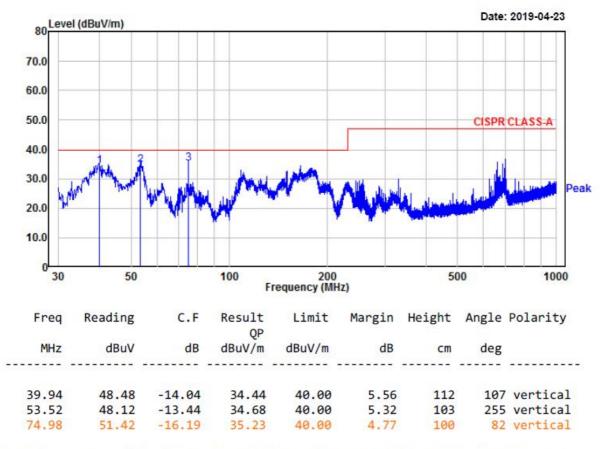
Tel: +82-31-3236008,9 Fax: +82-31-3236010

www.ltalab.com

EUT/Model No.: QNO-6082R Temp/Humi: 23 / 31

Test Mode : REC mode (POE)

Tested by: CHOI Y H



Remarks: C.F (Correction Factor) = Antenna factor + Cable loss - Preamp gain

Radiated Emission (Below 1 GHz) / H REC mode (POE)



4, Songjuro 236Beon-gil, yanggi-myeon,

Yongin-si, Gyeonggi-do, Korea

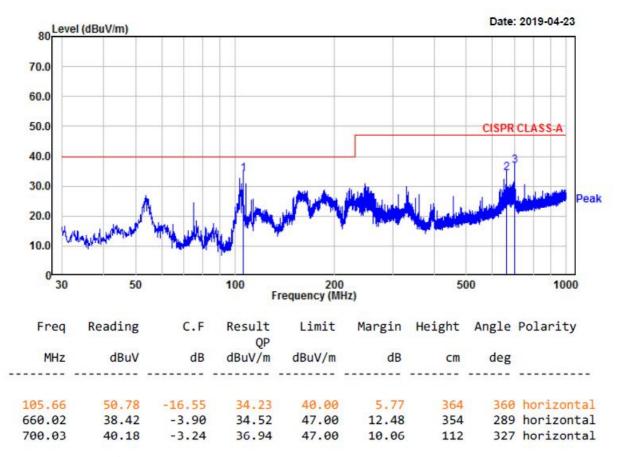
Tel: +82-31-3236008,9 Fax: +82-31-3236010

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EUT/Model No.: QNO-6082R Temp/Humi: 23 / 31

Test Mode : REC mode (POE)

Tested by: CHOI Y H



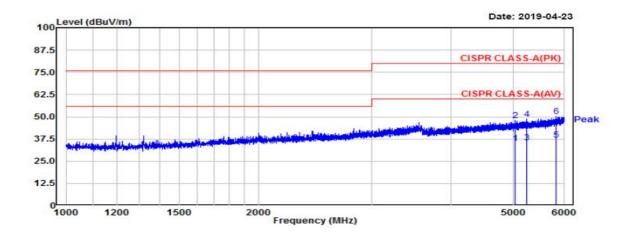
Remarks: C.F (Correction Factor) = Antenna factor + Cable loss - Preamp gain

Radiated Emission (Above 1 GHz) / REC mode (Adapter)

(Above 1 GHz) / V

EUT/Model No.: QNO-6082R Temp/Humi: 23 / 31

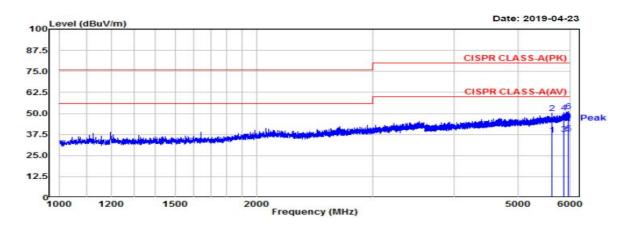
Test Mode : REC mode (Adapter) Tested by: CHOI Y H



(Above 1 GHz) / H

EUT/Model No.: QNO-6082R Temp/Humi: 23 / 31

Test Mode : REC mode (Adapter) Tested by: CHOI Y H



 Manufacture : HANWHA TECHWIN SECURITY VIETNAM CO.,LTD.
 Test Date
 Temp.: [c]
 Humidity: Distance (m)

 Model : QNO-6082R
 2019-04-23
 23
 31
 3.8

TEST mode : REC mode (Adapter)

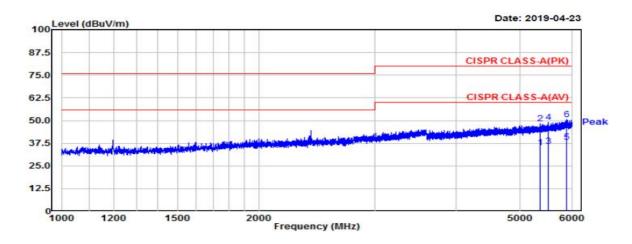
Freq.(MHz)	Reading(PK)	Reading(AV)	C.F	Result(PK)	Result(AV)	Limit(PK)	Limit(AV)	Margin(PK)	Margin(AV)	Height	Angle	Polarity
MHz	dBu∀	dBu∨	dB	dBuV/m	dBuV/m	dBuV/m	dBuV/m	dB	dB	cm	deg	Hor/Ver
5622.50	36.9	23.9	15.39	52.31	39, 24	80.0	60.0	27.69	20.76	100	351	Н
5863.13	36.0	23.1	16.55	52.59	39.69	80.0	60.0	27.41	20.31	100	48	Н
5969.38	36.0	22.8	17.24	53, 22	40.08	80.0	60.0	26.78	19.92	100	96	Н
5033, 13	36.4	23.5	13.53	49, 94	36,99	80.0	60.0	30.06	23.01	100	21	V
5243.13	36.6	23.7	14.01	50.57	37.66	80.0	60.0	29.43	22.34	100	33	V
5824.38	35.8	22.9	16.23	52.07	39.08	80.0	60.0	27.93	20.92	100	188	V

Radiated Emission (Above 1 GHz) / REC mode (POE)

(Above 1 GHz) / V

EUT/Model No.: QNO-6082R Temp/Humi: 23 / 31

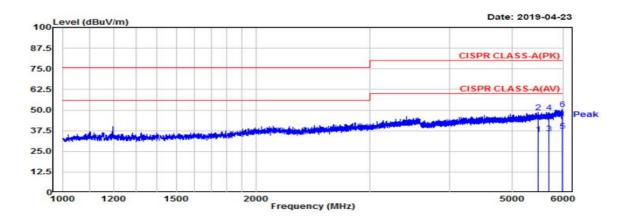
Test Mode : REC mode (POE) Tested by: CHOI Y H



(Above 1 GHz) / H

EUT/Model No.: QNO-6082R Temp/Humi: 23 / 31

Test Mode : REC mode (POE) Tested by: CHOI Y H



 Manufacture : HANWHA TECHWIN SECURITY VIETNAM CO.,LTD.
 Test Date
 Temp.: [τ]
 Humidity: [χ]
 Distance (m)

 Model : QNO-6082R
 2019-04-23
 23
 31
 3.8

TEST mode: REC mode (POE)

Freq.(MHz)	Reading(PK)	Reading(AV)	C.F	Result(PK)	Result(AV)	Limit(PK)	Limit(AV)	Margin(PK)	Margin(AV)	Height	Angle	Polarity
MHz	dBu∀	dBu∨	dB	dBuV/m	dBuV/m	dBuV/m	dBuV/m	dB	dB	cm	deg	Hor/Ver
5488.13	35.8	22.7	14.98	50.79	37.63	80.0	60.0	29.21	22.37	100	312	H
5708.75	35.3	22.3	15.54	50.84	37.88	80.0	60.0	29.16	22.12	100	360	Н
5990.63	35.2	22.2	17,06	52,50	39.51	00.0	60.0	27.47	20,49	100	46	Н
5359.38	35, 9	22.9	14.28	50.20	37.13	80.0	60.0	29,80	22.87	100	312	Ÿ
5530.00	36.3	23.2	14.75	51.02	37.90	80.0	60.0	28.98	22.10	100	278	V
5892.50	36.2	23.7	16.58	52.76	40.23	80,0	60.0	27.24	19.77	100	20	V

3.2.3 Harmonic Current (AC power input port)

Definition:

This part deals with the Limitation of harmonic currents injected into the public supply system.

We were performed the test according to LTA procedure LTA-QI-04.

Test method : EN 61000-3-2:2014
Test mode : REC mode (Adapter)

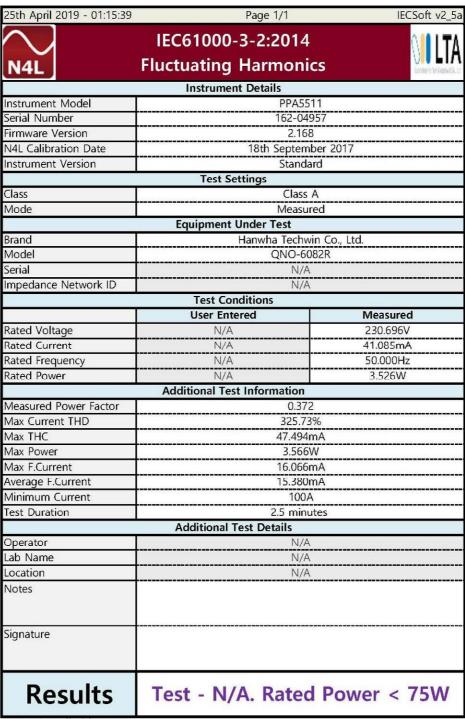
Rated power : 3.526 W

Result : Not Applicable

Measurement Data:

- We did not test EN61000-3-2 (Harmonic current emissions) for the QNO-6082R because equipment whose rated power is less or equal 75W don't need to be tested.

Harmonic Current (AC power input port) / REC mode (Adapter)



Test not applicable

With the exception of lighting equipment section 7 of the IEC61000-3-2:2014 standard declares that no Harmonic current limits are specified for equipment with a rated power of

3.2.4 Voltage Variation and Flicking (AC power input port)

Definition:

This section is concerned with the limitation of voltage fluctuations and flicker impressed on the public low-voltage system.

We were performed the test according to LTA procedure LTA-QI-04.

Test method : EN 61000-3-3:2013

Test mode : REC mode (Adapter)

Result : Complies

Measurement Data:

- Refer to the Next page

Voltage Variation and Flicking (AC power input port) / REC mode (Adapter)

25th April 2019 - 01:20:42	Page 1/2	IECSoft v2_5a				
	61000-3-3:2013 Ec					
N4L	Flickermeter	Doone of the Agran Co. Lic.				
	Instrument Details					
Instrument Model	PPA5511					
Serial Number	162-0-	4957				
Firmware Version	2.16	58				
N4L Calibration Date	18th Septer	nber 2017				
Instrument Version	Stanc	lard				
	Test Settings					
Class	Volta	nge				
Mode	Norma	l (4%)				
Minimum Current	10.	하루트를 하는 사람들은 아이들 아이들 아이들 가는 사람들이 되었다면 하는 아이들이 아이들이 들어 되었다면 하는 사람들이 아니는 사람들이 되었다.				
PST	10.00 m	inutes				
PLT	12 P	STs				
	Equipment Under Test					
Brand	Hanwha Tech					
Model	QNO-6	082R				
Serial	N/.					
Impedance Network ID	N/A	A				
	Test Conditions					
	User Entered	Measured				
Rated Voltage	N/A	230.695V				
Rated Current	N/A	N/A				
Rated Frequency	N/A	50.000Hz				
Rated Power	N/A	N/A				
D max	0.0779% (Li					
T max	0.0000 s (Li					
DC max	0.0078% (Li	mit: 3.3%)				
	Additional Test Details					
Operator	N/2					
Lab Name	N/.					
Location	N/.	Α				
Notes						
Signature						
Results	Phase1	: PASS				

25th Ap	ril 2019 - 01:20:42		Ph:1 Page 2/2 IECSoft					oft v2_5a
	I	C61000-3-3	:2013 Ed.3	0 Flickern	neter			
		Inst	rument De	etails				
Instrume	ent Model			PPA55	11			caree eterolónio
Instrume	ent Serial			162-049	957			
Instrume	ent Firmware			2.168	3			
		Equip	ment Und	er Test				
Brand			Hanv	vha Techw	in Co., I	_td.		
Model				QNO-60	182R			
Serial				N/A				
		Flic	ker Test Re	sults	-201			
PST no.	Status	DC (%)	Dmax (%)	Tmax (s)	PST	PST Li	m PLT	PLT Lir
1	Phase1: PASS	0.008	0.07793	0	0.082	1.00	0.082	N/A
2	Phase1: PASS	0.008	0.07793	0	0.082	1.00	0.082	N/A
3	Phase1: PASS	0.008	0.07793	0	0.082	1.00	0.082	N/A
4	Phase1: PASS	0.008	0.07793	0	0.082	1.00	0.082	N/A
5	Phase1: PASS	0.008	0.07793	0	0.082	1.00	0.082	N/A
6	Phase1: PASS	0.008	0.07793	0	0.082	1.00	0.082	N/A
7	Phase1: PASS	0.008	0.07793	0	0.082	1.00	0.082	N/A
8	Phase1: PASS	0.008	0.07793	0	0.082	1.00	0.082	N/A
9	Phase1: PASS	0.008	0.07793	0	0.082	1.00	0.082	N/A
10	Phase1: PASS		0.07793	О	0.082	1.00	0.082	N/A
11	Phase1: PASS	0.008	0.07793	lo	0.082	1.00	0.082	N/A
12	Phase1: PASS	0.008	0.07793	0	0.082	1.00	0.082	0.65

3.3 IMMUNITY

3.3.1 Electrostatic Discharge

Definition:

The test assesses the ability of the EUT to operate as intended in the event of an electrostatic discharge.

We were performed the test according to LTA procedure LTA-QI-04.

Test date : 2019.04.26.

Test method : EN 61000-4-2:2009

Temperature / Humidity / Pressure : 21 $^{\circ}$ C / 34 $^{\circ}$ R.H. / 101.0 kPa Discharge Impedance : $(330 \pm 10\%)\Omega$ / $(150 \pm 10\%)$ pF

Type of Discharge (air discharge) : $\pm 2kV, \pm 4kV, \pm 8kV$

Type of Discharge (contact discharge) : $\pm 6 \text{ kV}$

Number of discharges at each point : 10 of each polarity

Discharge Repetition on Rate : 1 / sec

Test mode : REC mode (Adapter), REC mode (POE)

Result : Complies

Measurement Data:

MODE: REC mode (Adapter)

1-1. Indirect Discharge

No.	Position	Kind of Discharge	Results	Remarks
1	НСР	Contact	Complies	No reaction recognized
2	VCP	Contact	Complies	No reaction recognized

1-2. Direct Discharge

No.	Position	Kind of Discharge	Result	Remarks
1	Enclosure	Contact	Complies	No reaction recognized
2	Lens	Air	Complies	No reaction recognized
3	ARM-OUT	Air	Complies	No reaction recognized
4	GND	Air	Complies	No reaction recognized
5	ARM-IN	Air	Complies	No reaction recognized
6	MIC	Air	Complies	No reaction recognized
7	LAN	Air	Complies	No reaction recognized
8	Screw	Contact	Complies	No reaction recognized
9	DC IN	Air	Complies	No reaction recognized

MODE: REC mode (POE)

2-1. Indirect Discharge

No.	Position	Kind of Discharge	Results	Remarks
1	НСР	Contact	Complies	No reaction recognized
2	VCP	Contact	Complies	No reaction recognized

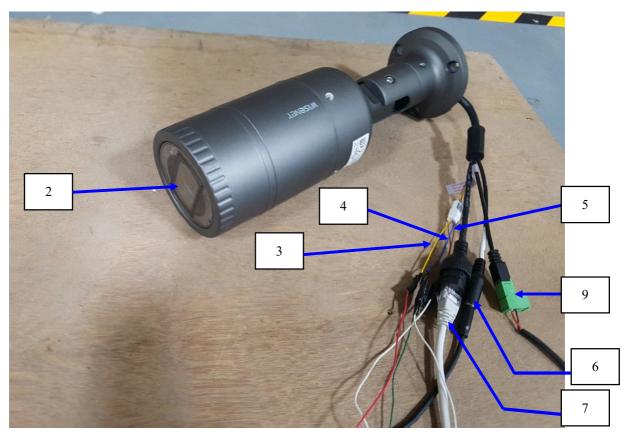
2-2. Direct Discharge

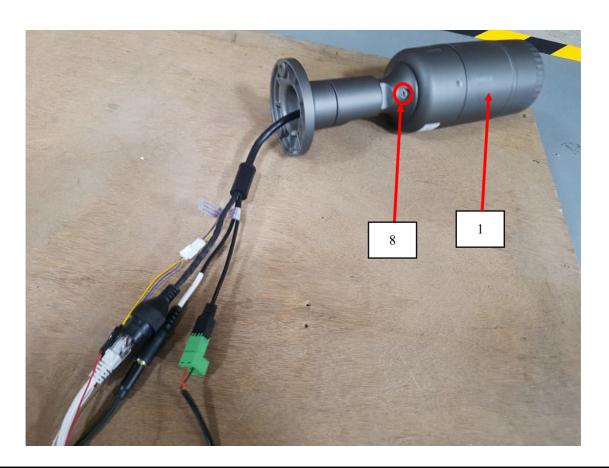
No.	Position	Kind of Discharge	Result	Remarks
1	Enclosure	Contact	Complies	No reaction recognized
2	Lens	Air	Complies	No reaction recognized
3	ARM-OUT	Air	Complies	No reaction recognized
4	GND	Air	Complies	No reaction recognized
5	ARM-IN	Air	Complies	No reaction recognized
6	MIC	Air	Complies	No reaction recognized
7	LAN	Air	Complies	No reaction recognized
8	Screw	Contact	Complies	No reaction recognized

^{*} Results are complies in each test mode.

Air discharge Contact discharge

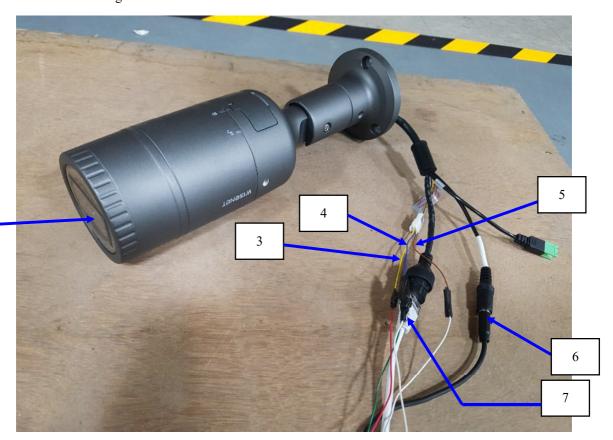
ESD TEST POINT / REC mode (Adapter)

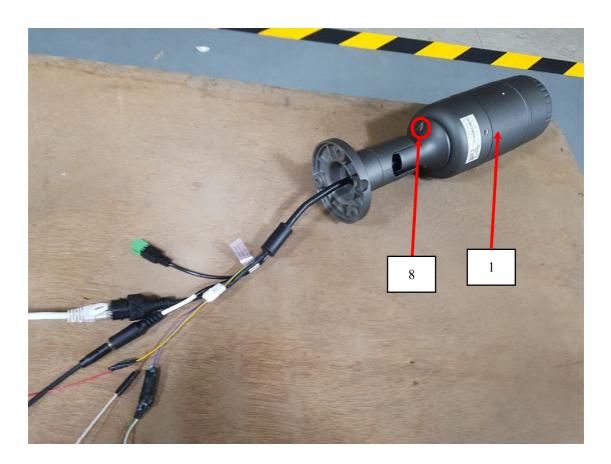




Air discharge Contact discharge

ESD TEST POINT / REC mode (POE)





3.3.2 RF Electromagnetic Field

Definition:

The test assesses the ability of the EUT to operate as intended in the presence of a radio frequency electromagnetic field disturbance.

We were performed the test according to LTA procedure LTA-QI-04.

Test date : 2019.04.24.

Test method : EN 61000-4-3:2006/A1:2008/A2:2010

Temperature / Humidity / Pressure : 23 °C / 33 % R.H. / 101 kPa

Frequency range : 80 MHz to 2,700 MHz

Test level : 10 V/m (measured unmodulated)

Amplitude Modulation : AM, 80 %, 1 $\,$ kHz Sinusoidal

PM, 1 Hz (0.5s ON: 0.5s OFF)

Step size : 1 % of fundamental

Dwell Time : 3 s

Test mode : REC mode (Adapter), REC mode (POE)

Result : Complies

Measurement Data:

MODE: REC mode (Adapter)

Port	Side	Result	Remarks
	Front	Complies	No reaction recognized
Horizontal	Left	Complies	No reaction recognized
Horizontai	Rear	Complies	No reaction recognized
	Right	Complies	No reaction recognized
	Front	Complies	No reaction recognized
Vertical	Left	Complies	No reaction recognized
verticai	Rear	Complies	No reaction recognized
	Right	Complies	No reaction recognized

MODE : REC mode (POE)

Port	Side	Result	Remarks	
	Front	Complies	No reaction recognized	
II'	Left	Complies	No reaction recognized	
Horizontal	Rear	Complies	No reaction recognized	
	Right	Complies	No reaction recognized	
Vertical	Front	Complies	No reaction recognized	
	Left	Complies	No reaction recognized	
	Rear	Complies	No reaction recognized	
	Right	Complies	No reaction recognized	

^{*} Results are complies in each test mode.

3.3.3 Electrical fast transients

Definition:

The test assesses the ability of the EUT to operate as intended in the event of fast transients presence on one of the input/output ports.

We were performed the test according to LTA procedure LTA-QI-04.

Test date : 2019.04.26.

Test method : EN 61000-4-4:2012

Temperature / Humidity / Pressure : 22 $^{\circ}$ C / 35 $^{\circ}$ R.H. / 101 kPa

Cable length : > 3 m

Test level : 2.0 kV (AC power input port)

1.0 kV (Signal port)

Polarity : Negative/ positive

Repetition frequency : 100 kHz

Test mode : REC mode (Adapter), REC mode (POE)

Result : Complies

Measurement Data:

MODE: REC mode (Adapter)

Power Line	Test level	Result	Remarks
L-N	$\pm 2 \text{ kV}$	Complies	No reaction recognized
Signal Line	Test level	Result	Remarks
LAN	± 1 kV	Complies	No reaction recognized

MODE: REC mode (POE)

Signal Line	Test level	Result	Remarks
LAN	± 1 kV	Complies	No reaction recognized

^{*} Results are complies in each test mode.

3.3.4 Surge

Definition:

The test assesses the ability of the EUT to operate as intended in the event of surge presence on the AC main power input ports.

We were performed the test according to LTA procedure LTA-QI-04.

Test date : 2019.04.26.

Test method : EN 61000-4-5:2014/A1:2017 Temperature / Humidity / Pressure : 22 $^{\circ}$ C / 35 $^{\circ}$ R.H. / 101 kPa Test level : \pm 0.5 kV, \pm 1 kV (line to line)

 \pm 0.5 kV, \pm 1 kV, \pm 2 kV (line to ground),

 \pm 0.5 kV, \pm 1 kV (signal line)

Polarity : Negative/ positive

Wave shape : $1.2/50 \mu s$ pulse

Number of surges : 5 (at each phase)

Test mode : REC mode (Adapter), REC mode (POE)

Result : Complies

Measurement Data:

MODE: REC mode (Adapter)

Phase	Line	level	Result	Remark
0°	Line(L) to line(N)	$\pm 0.5, 1.0 \mathrm{kV}$	Complies	No reaction recognized
90°	Line(L) to line(N)	$\pm 0.5, 1.0 \mathrm{kV}$	Complies	No reaction recognized
180°	Line(L) to line(N)	$\pm 0.5, 1.0 \mathrm{kV}$	Complies	No reaction recognized
270°	Line(L) to line(N)	$\pm 0.5, 1.0 \mathrm{kV}$	Complies	No reaction recognized

Signal Line	Test level	Result	Remarks
LAN	$\pm 0.5, 1.0 \mathrm{kV}$	Complies	No reaction recognized

MODE: REC mode (POE)

Signal Line	Test level	Result	Remarks
LAN	$\pm 0.5, 1.0 \mathrm{kV}$	Complies	No reaction recognized

^{*} Results are complies in each test mode.

3.3.5 Conducted disturbances, induced by radio-frequency fields

Definition:

The test assesses the ability of the EUT to operate as intended in the presence of a radio frequency electromagnetic disturbance on the input/output ports.

We were performed the test according to LTA procedure LTA-QI-04.

Test date : 2019.04.24.

Test method : EN 61000-4-6:2014/AC:2015 Temperature / Humidity / Pressure : 23 $^{\circ}$ C / 37 $^{\circ}$ R.H. / 101 kPa

Frequency range : 0.15MHz -100 MHz

Test level : 10 Vrms unmodulated

Amplitude Modulation : AM, 80 %, 1 kHz Sinusoidal

PM, 1 Hz (0.5s ON: 0.5s OFF)

Step size : 1 % of fundamental.

Test mode : REC mode (Adapter), REC mode (POE)

Result : Complies

Measurement Data:

MODE: REC mode (Adapter)

Power Port	Test level (Vrms)	Result	Remarks
Power	10	Complies	No reaction recognized
Signal Port	Test level (Vrms)	Result	Remarks
LAN	10	Complies	No reaction recognized

MODE: REC mode (POE)

Power Port	Test level (Vrms)	Result	Remarks
LAN	10	Complies	No reaction recognized

^{*} Results are complies in each test mode.

3.3.6 Mains supply voltage dips, short interruptions

Definition:

The test assesses the ability of the EUT to operate as intended in the event of voltage dips and interruptions present on the AC mains power input ports.

We were performed the test according to LTA procedure LTA-QI-04.

Test date : 2019.04.26.

Test method : EN 61000-4-11:2004/A1:2017 Temperature / Humidity / Pressure : 23 $^{\circ}$ C / 34 $^{\circ}$ R.H. / 101 kPa

Ut : 230 Vac

Test mode : REC mode (Adapter)

Result : Complies

Measurement Data:

MODE: REC mode (Adapter)

Test Level %Ut	Voltage droop and interruptions %Ut	Duration of Reduction (period)	Result	Remarks
80	20	250	Complies (A)	No reaction recognized
70	30	25	Complies (A)	No reaction recognized
40	60	10	Complies (A)	No reaction recognized
0	100	250	Complies (B)	EUT Power OFF during the test. Automatic replay without user's control. After the test, EUT was operated normally.

3.3.7 Mains supply voltage variations

Definition:

The test assesses the ability of the EUT to operate as intended in the event of voltage variations present on the AC mains power input ports.

We were performed the test according to LTA procedure LTA-QI-04.

Test date : 2019.04.26.

Test method : EN 50130-4:2011/A1:2014 Temperature / Humidity / Pressure : 23 $^{\circ}$ / 34 $^{\circ}$ R.H. / 101 kPa

Supply Voltage maximum : Unom + 10 % Supply Voltage minimum : Unom - 15 %

Ut : 230 Vac

Test mode : REC mode (Adapter)

Result : Complies

Measurement Data:

Unom = Nominal mains voltage. Where provision is made to adapt the equipment to suit a number of nominal supply voltages (e.g. by transformer tap changing), the above conditioning severity shall be applied for each nominal voltage, with the equipment suitably adapted. For equipment which is claimed to be suitable for a range of nominal mains voltages (e.g. 220/240 V) without adaptation, Umax = (Maximum Unom) + 10 %, and Umin = (Minimum Unom) p 15 %. In any case the range of Unom must include the European nominal mains voltage of 230 V.

2 Mains supply voltage variations

MODE: REC mode (Adapter) / 230 V, 50 Hz

Test Lev	velCondition	Test Level (V)	Result	Remarks
Unom	+10%	253	Complies	No reaction recognized
Unom	-15%	195.5	Complies	No reaction recognized

APPENDIX A

TEST EQUIPMENT AND ANCILLARIES USED FOR TESTS

To facilitate inclusion on each page of the test equipment used for related tests, each item of test equipment are identified by the Test Laboratory.

Conducted emissions

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
\boxtimes	EMI TEST Receiver	ESR	Rohde & Schwarz	101499	2019.07.11	1 year
\boxtimes	Pulse Limiter	ESH3-Z2	Rohde & Schwarz	100710	2020.03.16	1 year
	LISN	ESH3-Z6	Rohde & Schwarz	100378	2019.09.07	1 year
	LISN	ESH3-Z6	Rohde & Schwarz	101468	2019.09.07	1 year
\boxtimes	LISN(main)	ENV216	Rohde & Schwarz	100408	2019.10.10	1 year
\boxtimes	LISN(sub)	LT32C/10	AFJ	32031518210	2019.09.06	1 year
\boxtimes	TEST PROGRAM	e3_ce 20181212a (V9)	AUDIX	-	-	-
\boxtimes	ISN	ISN T800	TESEQ	27109	2019.09.12	1 year
	ISN	ENY81-CA6	Rohde & Schwarz	101565	2019.09.12	1 year
	CURRENT PROBE	EZ-17	Rohde & Schwarz	100508	2019.09.06	1 year

Radiated Emission – Below 1 GHz

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
\boxtimes	EMI TEST Receiver	ESU	Rohde & Schwarz	100092	2019.09.06	1 year
\boxtimes	Amplifier (25 dB)	8447D	HP	2944A07684	2019.09.06	1 year
\boxtimes	BILOG Antenna	VULB9168	SCHWARZBECK	775	2020.03.16 (KOLAS)	2 year
\boxtimes	TEST PROGRAM	e3 20181212a (V9)	AUDIX	-	-	-

Radiated Emission – Above 1 GHz

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
\boxtimes	EMI TEST Receiver	ESU	Rohde & Schwarz	100092	2019.09.06	1 year
\boxtimes	Amplifier	8449B	HP	3008A00671	2019.09.06	1 year
\boxtimes	HORN ANTENNA	3115	ETS	114105	2019.11.03 (KOLAS)	2 year
\boxtimes	TEST PROGRAM	e3 20181212a (V9)	AUDIX	-	-	-

Harmonic Current / Voltage Variation and Flicking

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
\boxtimes	Precision Power Analyzer	PPA5511	Newtons4th Ltd	162-04957	2019.09.10	1 year
	Reference Impedance Network	ES4152	NF Corp.	9074424	2019.09.07	1 year

Electrostatic Discharge

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
	ESD Simulator	ESS-2000	NOISEKEN	8000C03241	2019.09.11	1 year
\boxtimes	ESD GUN	TC-815R	NOISEKEN	ESS0564361	2019.09.11	1 year

RF Electromagnetic Field

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
\boxtimes	Signal Generator	E4432B	Agilent	MY41310632	2020.03.16	1 year
\square	Power Meter	E4419B	Agilent	GB38410133	2020.03.16	1 year
\boxtimes	Power Sensor	E9300A	Agilent	MY41497992	2020.03.16	1 year
\boxtimes	Power Sensor	E9300A	Agilent	MY41497618	2020.03.16	1 year
\boxtimes	RF POWER AMPLIFIER	ITA0300KL-300	INFINITECH	0300KL 1507 001	-	-
\boxtimes	RF POWER AMPLIFIER	ITA2000KL-120	INFINITECH	200KL 1507 001	-	-
\boxtimes	RF POWER AMPLIFIER	ITA4500KL-70	INFINITECH	4500KL 1507 001	-	-
\boxtimes	RF POWER AMPLIFIER	ITA0750KL-300	INFINITECH	0750KL 1507 001	-	-
\boxtimes	LogPer.Antenna (80 MHz ~ 3 GHz)	K9128	RAPA	NONE	-	-

Electrical fast transients

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
	Compact Generator	Compact NX	EMTEST	P1725200196	2019.09.06	1 year
	AC Power Source	Variac NX	EMTEST	P1745207276	2019.09.06	1 year
\boxtimes	Capacitive Coupling Clamp	CCI	EMTEST	P1744207071	2019.09.06	1 year

Surge

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
	Compact Generator	Compact NX	EMTEST	P1725200196	2019.09.06	1 year
	AC Power Source	Variac NX	EMTEST	P1745207276	2019.09.06	1 year
\boxtimes	CDN	CNV 508T5	EMTEST	P1742204978	2019.09.07	1 year
	CDN	CNV 508N1	EMTEST	P1742204940	2019.09.07	1 year

Conducted disturbances, induced by radio-frequency fields

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
\boxtimes	Signal generator	SML03	R&S	103026/0013	2020.03.16	1 year
	POWER METER	NRVD	R&S	101689	2020.03.16	1 year
\boxtimes	POWER Sensor	URV5-Z2	R&S	100755	2020.03.16	1 year
\boxtimes	POWER Sensor	URV5-Z2	R&S	100756	2020.03.16	1 year
\boxtimes	RF Power Amplifier	FLL75A	FRANKONIA	1033	-	-
\boxtimes	EM INJECTION CLAMP	TSIC-23	F.C.C	529	2020.03.25	1 year
	CDN (M1)	TSCDN-M1-16A	F.C.C	07004	2020.03.16	1 year
\boxtimes	CDN (M2) (main)	TSCDN-M2-16A	F.C.C	07008	2019.09.06	1 year
	CDN (M2)	TSCDN-M2-16A	F.C.C	07009	2020.03.16	1 year
	CDN (M3) (sub)	TSCDN-M3-16A	F.C.C	07016	2020.03.16	1 year
	CDN (M3) (main)	TSCDN-M3-16A	F.C.C	07017	2019.09.06	1 year

Mains supply voltage dips, short interruptions

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
\boxtimes	Compact Generator	Compact NX	EMTEST	P1725200196	2019.09.06	1 year
\boxtimes	AC Power Source	Variac NX	EMTEST	P1745207276	2019.09.06	1 year

Mains supply voltage variations

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
\boxtimes	Compact Generator	Compact NX	EMTEST	P1725200196	2019.09.06	1 year
	AC Power Source	Variac NX	EMTEST	P1745207276	2019.09.06	1 year

APPENDIX B

PERFORMANCE CRITERIA

Performance criteria

The variety and the diversity of the apparatus within the scope of this document makes it difficult to define precise criteria for the evaluation of the immunity test results.

If as a result of the application of the tests defined in this standard, the apparatus becomes dangerous or unsafe then the apparatus shall be deemed to have failed the test.

A functional description and a definition of performance by the manufacture and noted in the test report, based on the following criteria:

Electrostatic discharge

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the application of discharge is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change. The EUT shall meet the acceptance criteria for the functional test (see Clause 6), after the conditioning.

Radiated electromagnetic fields

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change, and no such flickering of indicators occurs at a field strength of 3 V/m.

For components of CCTV systems, where the status is monitored by observing the TV picture, then deterioration of the picture is allowed at 10 V/m, providing.

(a) there is no permanent damage or change to the EUT

(e.g. no corruption of memory or changes to programmable setting etc.)

(b) at 3 V/m, any deterioration of the picture is so minor that the system could still be used; and

(c) there is no observable deterioration of the picture at 1 V/m.

The EUT shall meet the acceptance criteria for the functional test(see Clause 6), after the conditioning.

Fast transient burst / slow high energy voltage surge

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the application of the bursts is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change. The EUT shall meet the acceptance criteria for the functional test (see Clause 6), after the conditioning.

Slow high energy voltage surge

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the application of the surges is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change. The EUT shall meet the acceptance criteria for the functional test (see Clause 6), after the conditioning.

Conducted RF immunity

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change, and no such flickering of indicators occurs at $U0 = 130 \text{ dB}\mu\text{N}$.

For components of CCTV systems, where the status is monitored by observing the TV picture, then deterioration of the picture is allowed at $U0 = 140 \text{ dB}\mu\text{V}$, providing

- (a) there is no permanent damage or change to the EUT
 - (e.g. no corruption of memory or changes to programmable settings, etc.)
- (b) at $U0 = 130 \text{ dB}\mu\text{V}$, any deterioration of the picture is so minor that the system could still be used, and
- (c) there is no observable deterioration of the picture at $U0 = 120 \text{ dB}\mu N$.

The EUT shall meet the acceptance criteria for the functional test(see Clause 6), after the conditioning.

Voltage dip/interruption

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change. The EUT shall meet the acceptance criteria for the functional test(see Clause 6), after the conditioning.

It is permitted to use ancillary equipment (e.g. A UPS) to meet the requirements of this clause. This shall be detailed in the test report and the manufacturer's installation manual. Signaling a mains fault during the 100 % voltage reduction test is permitted.

Mains supply voltage variations

There shall be no damage, malfunction or change of status due to the different supply voltage conditions. The EUT shall meet the acceptance criteria for the functional test(see Clause 6), during the conditioning.

APPENDIX C

PHOTOGRAPHS

Conducted emission (Maximum emission configuration) / REC mode (Adapter)



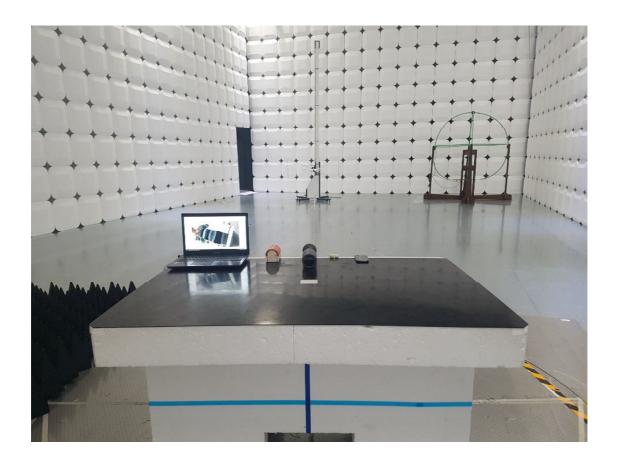


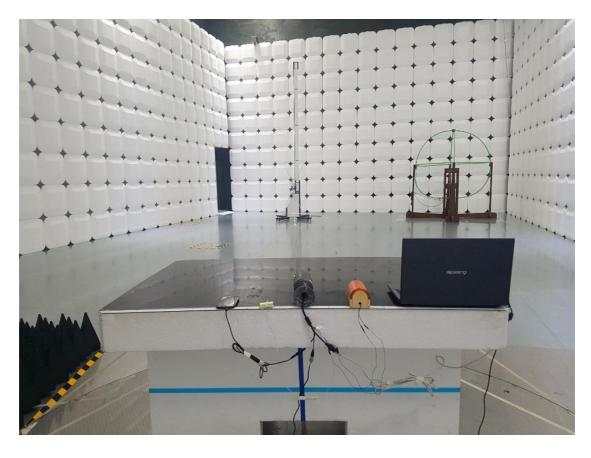


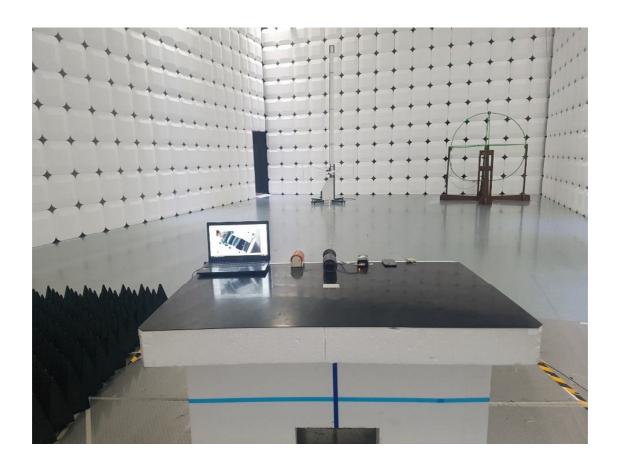


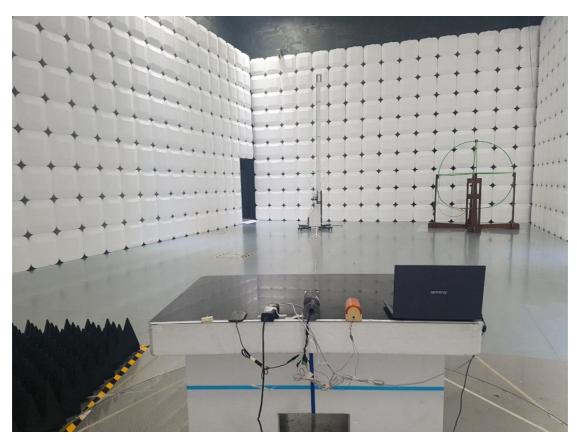


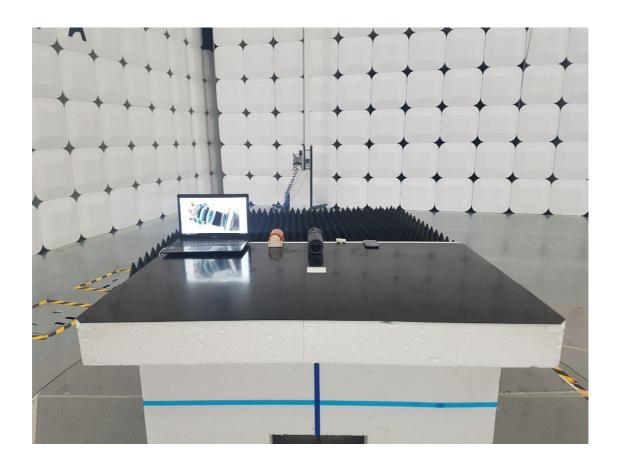


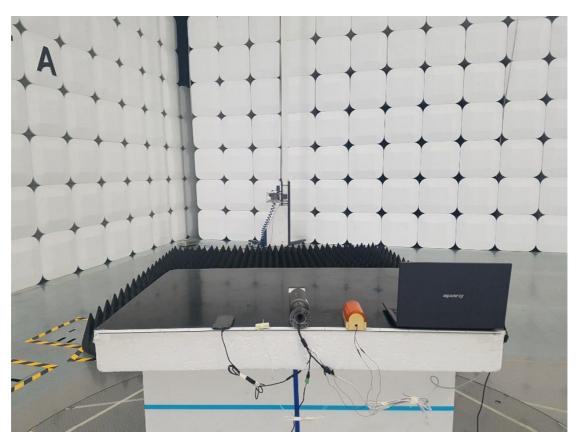


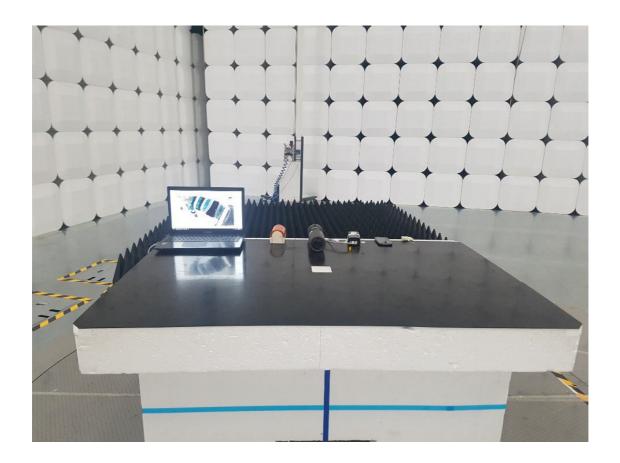


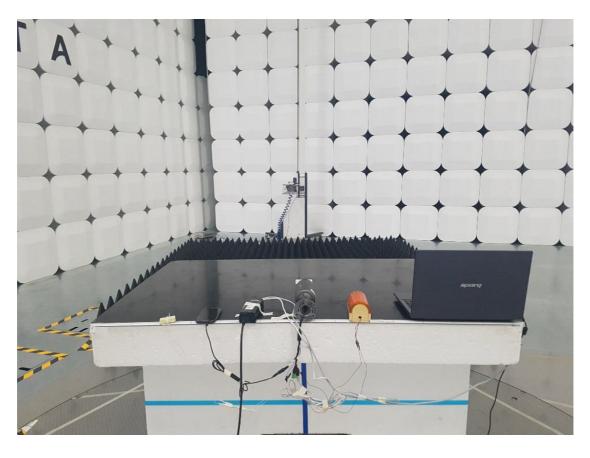












Harmonic Current / Voltage Variation and Flicking REC mode (Adapter)



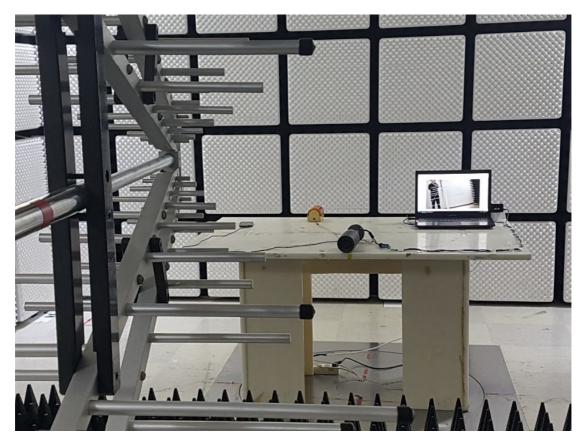
Electrostatic discharge / REC mode (Adapter)



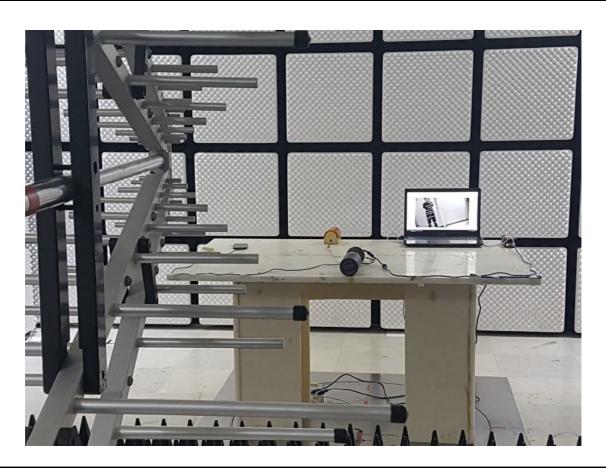
Electrostatic discharge / REC mode (POE)



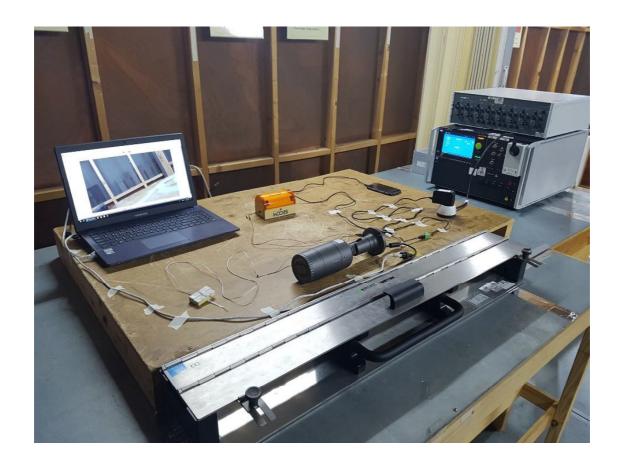
RF Electromagnetic Field / REC mode (Adapter)



RF Electromagnetic Field / REC mode (POE)



Electrical fast transients / REC mode (Adapter)





Electrical fast transients / REC mode (POE)



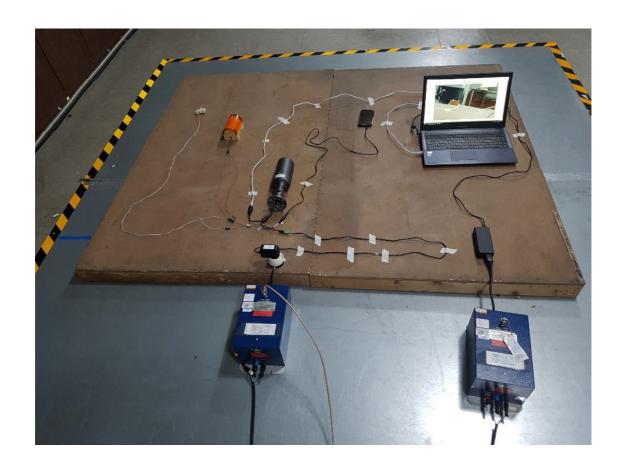
Surge / REC mode (Adapter)

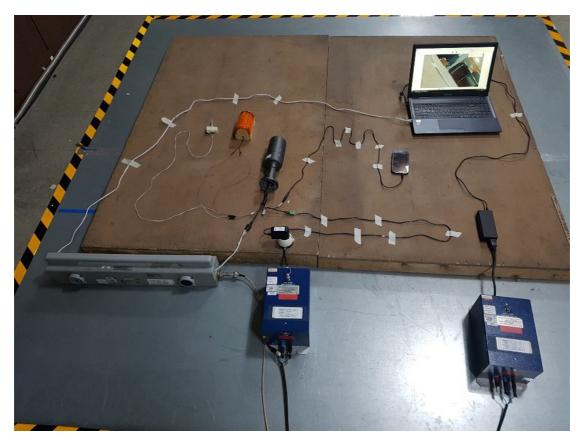




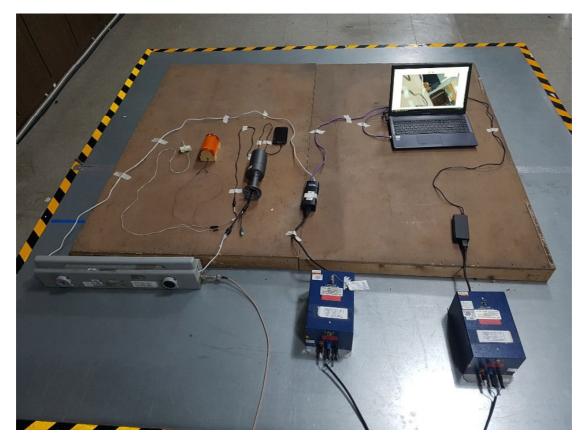
Surge / REC mode (POE)







Conducted Disturbances, Induced by Radio-Frequency Fields / REC mode (POE)



Main supply voltage (dips, variations) short interruptions / REC mode (Adapter)







EUT

